

## Single P-Channel MOSFET

### ■ DESCRIPTION

SMC4237M is the P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior, fast switching performance. These devices are well suited for high efficiency fast switching applications.

### ■ PART NUMBER INFORMATION

**SMC 4237 M - TR G**

a	b	c	d	e
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a : Company name.

b : Product Serial number.

c : Package code M:SOP-8

d : Handling code TR:Tape&Reel

e : Green produce code G:*RoHS Compliant*

### ■ FEATURES

$$V_{DS} = -20V, \quad I_D = -11.5A$$

$$R_{DS(ON)} = 12m\Omega(Typ.) @ V_{GS} = -10V$$

$$R_{DS(ON)} = 14m\Omega(Typ.) @ V_{GS} = -4.5V$$

$$R_{DS(ON)} = 18m\Omega(Typ.) @ V_{GS} = -2.5V$$

$$R_{DS(ON)} = 23m\Omega(Typ.) @ V_{GS} = -1.8V$$

◆Fast switch

◆Low gate charge

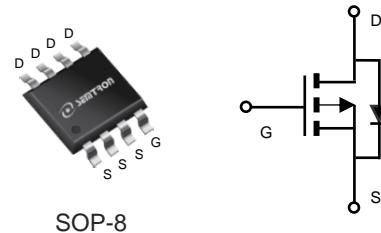
◆High power and current handling capability

### ■ APPLICATIONS

◆LED Application

◆Portable Equipment

◆DC-DC Power Management



### ■ ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ C$ Unless otherwise noted)

Symbol	Parameter	Rating	Units	
$V_{DSS}$	Drain-Source Voltage	-20	V	
$V_{GSS}$	Gate-Source Voltage	$\pm 12$	V	
$I_D$	Continuous Drain Current ( $V_{GS} = -4.5V$ )	$T_A = 25^\circ C$ $T_A = 70^\circ C$	-11.5 -9.2	A
$I_{DM}$	Pulsed Drain Current <sup>A</sup>	-46	A	
$I_{AS}$	Avalanche Current <sup>A</sup>	-25	A	
$E_{AS}$	Single Pulse Avalanche energy L=0.1mH <sup>AD</sup>	31	mJ	
$P_D$	Power Dissipation <sup>B</sup>	$T_A = 25^\circ C$ $T_A = 70^\circ C$	3.6 2.3	W
$T_J$	Operation Junction Temperature	-55/150	°C	
$T_{STG}$	Storage Temperature Range	-55/150	°C	

### ■ THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient <sup>B</sup>	$t \leq 10s$	35	°C/W
	Thermal Resistance Junction to Ambient <sup>BC</sup>	Steady-State	70	

**ELECTRICAL CHARACTERISTICS( $T_A = 25^\circ\text{C}$  Unless otherwise noted)**

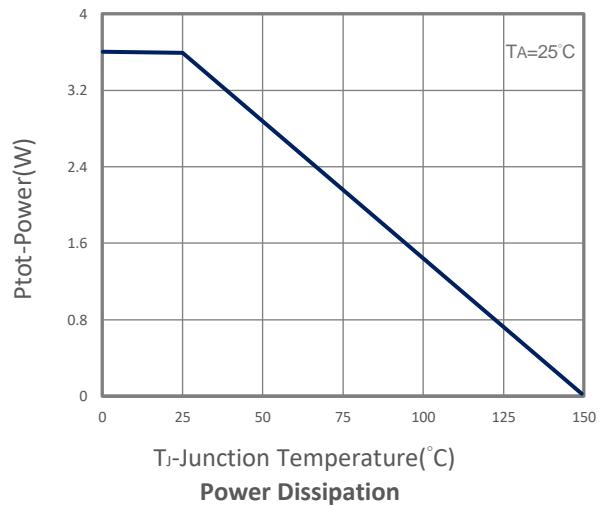
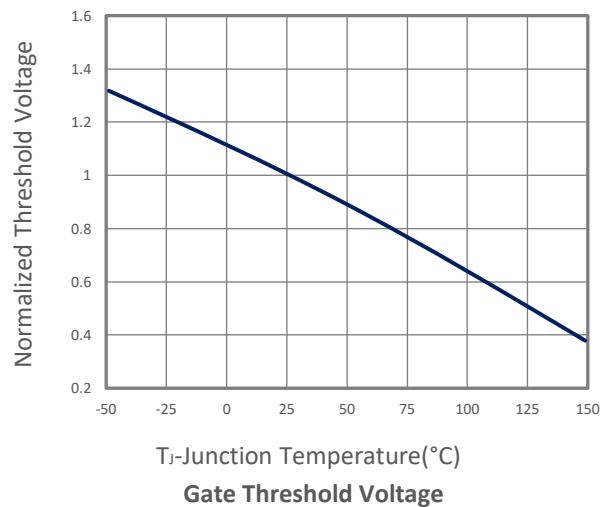
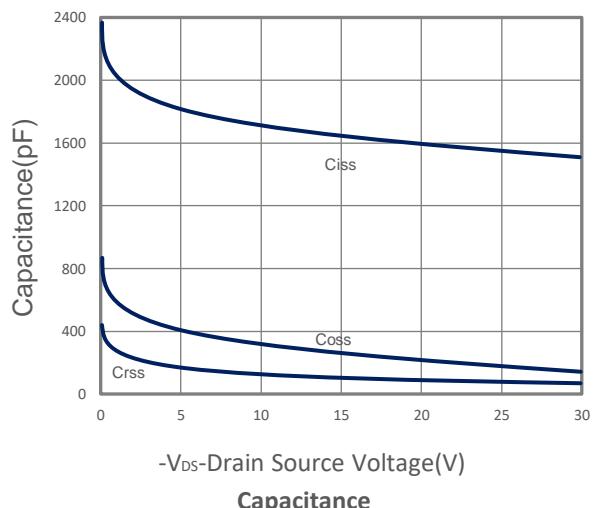
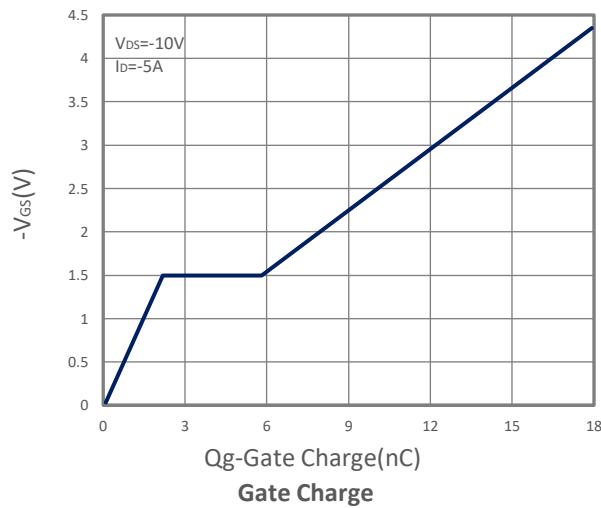
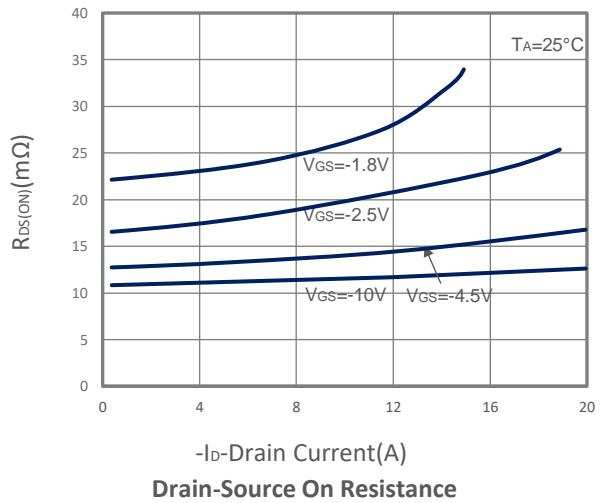
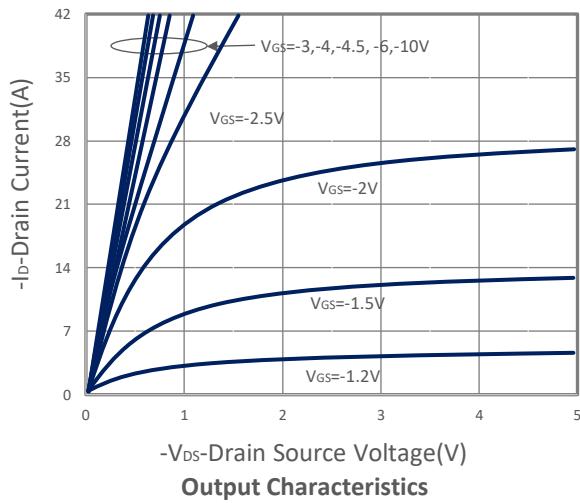
Symbol	Parameter	Condition	Min	Typ	Max	Unit	
<b>Static Parameters</b>							
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=-250\mu\text{A}$	-20			V	
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-0.4	-0.6	-1	V	
$I_{GSS}$	Gate Leakage Current	$V_{DS}=0\text{V}, V_{GS}=\pm 12\text{V}$			$\pm 100$	nA	
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=-20\text{V}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$			-1	$\mu\text{A}$	
		$V_{DS}=-16\text{V}, V_{GS}=0\text{V}, T_J=75^\circ\text{C}$			-10		
$R_{DS(\text{ON})}$	Drain-source On-Resistance	$V_{GS}=-10\text{V}, I_D=-11.5\text{A}$		12	15	$\text{m}\Omega$	
		$V_{GS}=-4.5\text{V}, I_D=-8\text{A}$		14	17		
		$V_{GS}=-2.5\text{V}, I_D=-5\text{A}$		18	22		
		$V_{GS}=-1.8\text{V}, I_D=-3\text{A}$		23	28		
$G_f$	Forward Transconductance	$V_{DS}=-10\text{V}, I_D=-10\text{A}$		33		S	
<b>Diode Characteristics</b>							
$V_{SD}$	Diode Forward Voltage	$I_S=-1\text{A}, V_{GS}=0\text{V}$			-1	V	
$I_S$	Diode Continuous Current				-5.2	A	
$t_{rr}$	Reverse Recovery Time			16.8		ns	
$Q_{rr}$	Reverse Recovery Charge	$I_S=-10\text{A}, dI/dt=100\text{A}/\mu\text{s}$		8		nC	
<b>Dynamic and Switching Parameters</b>							
$Q_g$	Total Gate Charge	$V_{DS}=-10\text{V}, V_{GS}=-4.5\text{V}, I_D=-5\text{A}$		39	54	nC	
$Q_g$	Total Gate Charge (4.5V)			19	26.6		
$Q_{gs}$	Gate-Source Charge			2.1	2.9		
$Q_{gd}$	Gate-Drain Charge			3.8	5.3		
$C_{iss}$	Input Capacitance	$V_{DS}=-10\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		1680		pF	
$C_{oss}$	Output Capacitance			228			
$C_{rss}$	Reverse Transfer Capacitance			115			
$t_{d(on)}$	Turn-On Time	$V_{DD}=-10\text{V}, V_{GEN}=-4.5\text{V}$		10	19	nS	
$t_r$				38	72		
$t_{d(off)}$	Turn-Off Time		$R_G=10\Omega, I_D=-1\text{A}$	86	163		
$t_f$				25	48		

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

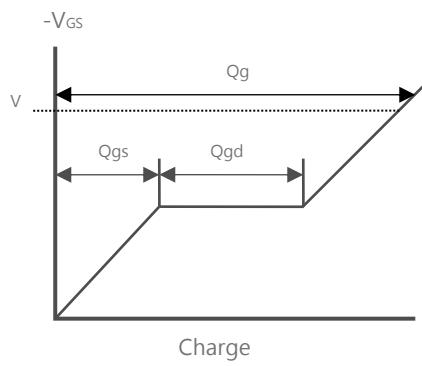
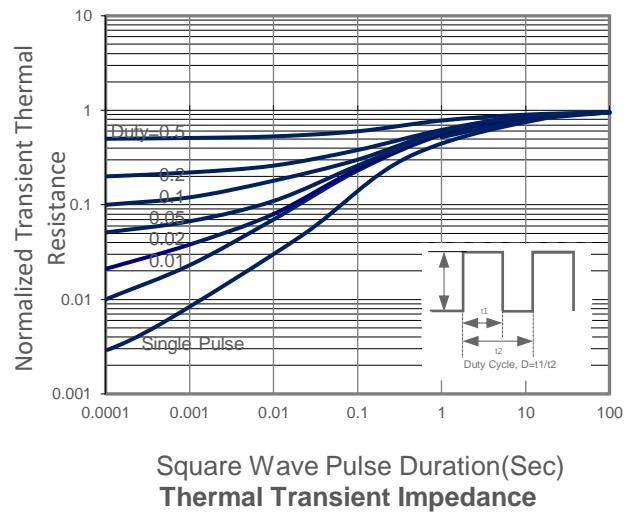
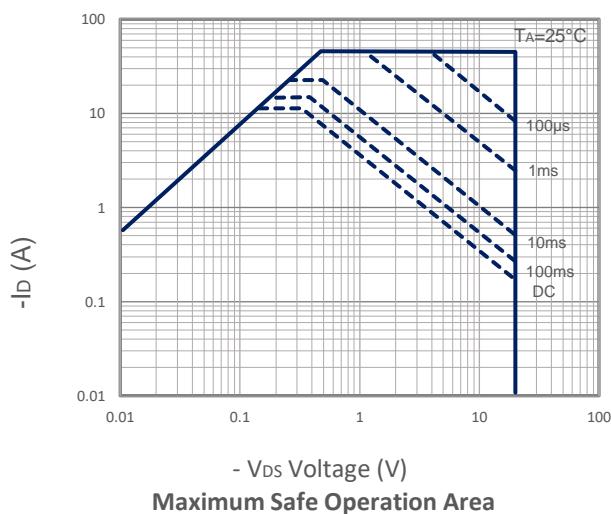
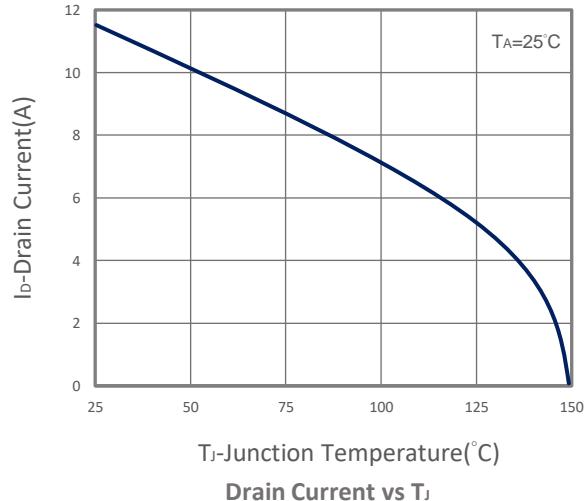
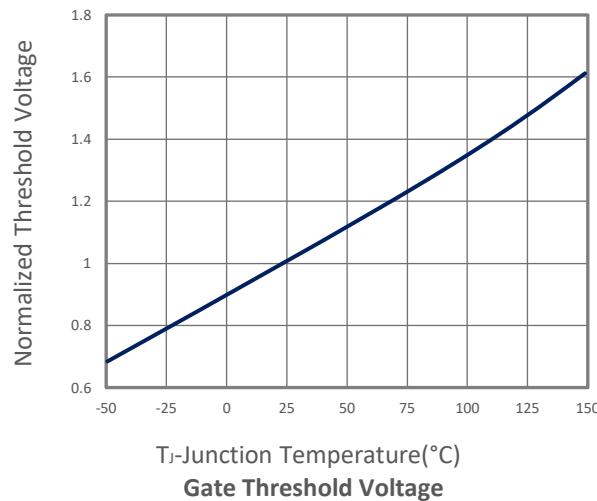
- A. Pulsed width limited by maximum junction temperature,  $T_J(\text{MAX})=150^\circ\text{C}$ .
- B. The value of  $R_{eJA}$  is measured with the device mounted on 1in2 FR-4 board in a still air environment with maximum junction temperature  $T_J(\text{MAX})=150^\circ\text{C}$  (initial temperature  $T_A=25^\circ\text{C}$ ).
- C.  $T_J(\text{MAX})=150^\circ\text{C}$ , using junction-to-case thermal resistance ( $R_{eJC}$ ) is more useful in additional heat sinking is used.
- D. The EAS data shows Max, tested and pulse width limited by  $T_J(\text{MAX})=150^\circ\text{C}$  (initial temperature  $T_J=25^\circ\text{C}$ ).

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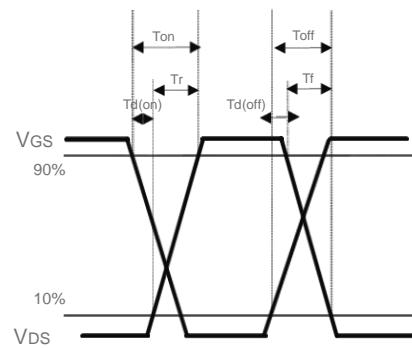
## ■ TYPICAL CHARACTERISTICS



## TYPICAL CHARACTERISTICS

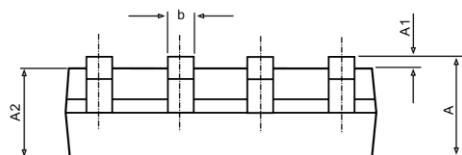
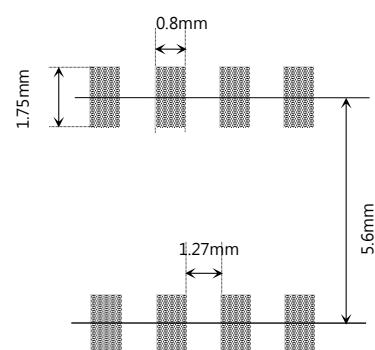
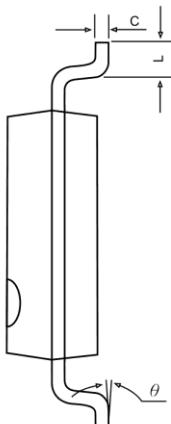
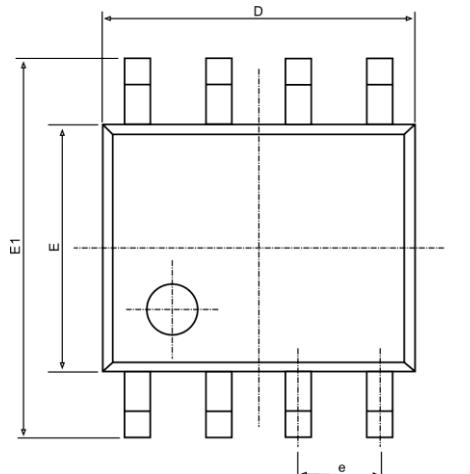


Gate Charge Waveform



Switching Time Waveform

## SOP-8 PACKAGE DIMENSIONS



Recommended Land Pattern

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.040.	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.130	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270BSC.		0.050BSC.	
L	0.400	1.270	0.016	0.005
$\Theta$	$0^\circ$	$8^\circ$	$0^\circ$	$8^\circ$